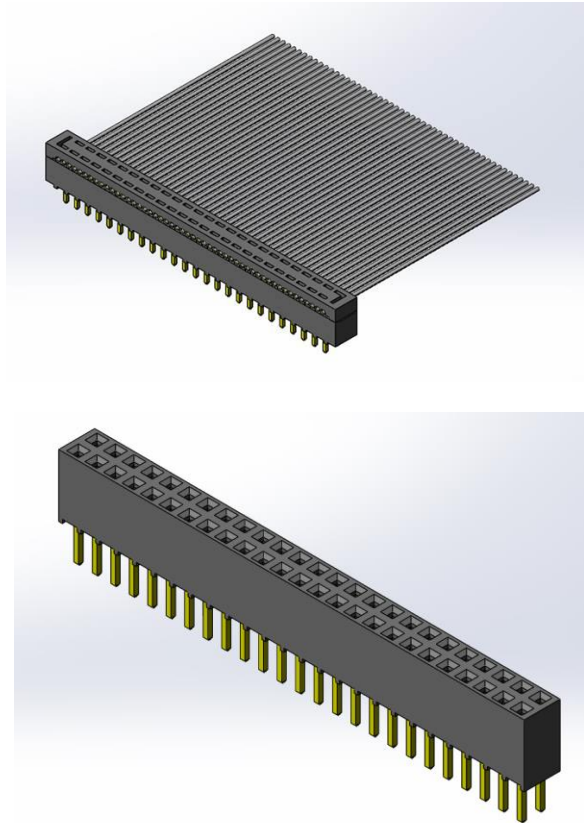




Project Number: Design Qualification Test Report	Tracking Code: 579717_Report_Rev_2
Requested by: Catie Eichhorn	Date: 10/17/2017
Part #: HCMD-25-S-06.00-01-G/SSQ-125-01-T-D	Tech: Peter Chen
Part description: HCMD/SSQ	Qty to test: 80
Test Start: 07/10/2015	Test Completed: 08/16/2015



DESIGN QUALIFICATION TEST REPORT

HCMD/SSQ
HCMD-25-S-06.00-01-G/SSQ-125-01-T-D

Tracking Code:579717_Report_Rev_1	Part #: HCMD-25-S-06.00-01-G/SSQ-125-01-T-D
Part description: HCMD/SSQ	

REVISION HISTORY

DATA	REV.NUM.	DESCRIPTION	ENG
9/26/2016	1	Initial Issue	PC
10/17/2017	2	Add the cable pull force data	PC

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCR and DWV/IR testing were cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCR and DWV/IR are visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead free
- 9) Samtec Test PCBs used: PCB-106973-TST/ PCB-106974-TST/ PCB-106975-TST

FLOWCHARTS

Gas Tight

Group 1

HCMD-25-S-06.00-01-G

SSQ-125-01-T-D

8 Assemblies

Step	Description
1.	LLCR (2)
2.	Gas Tight (1)
3.	LLCR (2)

Max Delta = 15 mOhm

(1) Gas Tight = EIA-364-36

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

Thermal Aging

Group 1

HCMD-25-S-06.00-01-G

SSQ-125-01-T-D

8 Assemblies

LLCR Group

Step	Description
1.	LLCR (1)
2.	Thermal Age (3)
3.	LLCR (1)

Max Delta = 15 mOhm

Group 2

HCMD-25-S-06.00-01-G

SSQ-125-01-T-D

8 Assemblies

Force Group

*Note: remove cable for force
measurement*

Step	Description
1.	Mating/Unmating Force (2)
2.	Thermal Age (3)
3.	Mating/Unmating Force (2)

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mating/Unmating Force = EIA-364-13

(3) Thermal Age = EIA-364-17

Test Condition = 4 (105°C)

Time Condition = 8 (250 Hours)

FLOWCHARTS Continued**Mating/Unmating/Durability***Note: Remove cable for force measurement.*

Group 1 HCMD-25-S-06.00-01-G SSQ-125-01-T-D 8 Assemblies LLCR Group		Group 2 HCMD-05-S-06.00-01-G SSQ-105-01-T-D 8 Assemblies		Group 3 HCMD-36-S-06.00-01-G SSQ-136-01-T-D 8 Assemblies		Group 4 HCMD-25-S-06.00-01-G SSQ-125-01-T-D 8 Assemblies Force Group	
Step	Description	Step	Description	Step	Description	Step	Description
1.	LLCR (2)	1.	Mating/Unmating Force (3)	1.	Mating/Unmating Force (3)	1.	Mating/Unmating Force (3)
2.	Cycles Quantity = 100 Cycles	2.	Cycles Quantity = 25 Cycles	2.	Cycles Quantity = 25 Cycles	2.	Cycles Quantity = 25 Cycles
3.	LLCR (2)	3.	Mating/Unmating Force (3)	3.	Mating/Unmating Force (3)	3.	Mating/Unmating Force (3)
4.	Max Delta = 15 mOhm	4.	Cycles Quantity = 25 Cycles	4.	Cycles Quantity = 25 Cycles	4.	Cycles Quantity = 25 Cycles
5.	Thermal Shock (4)	5.	Mating/Unmating Force (3)	5.	Mating/Unmating Force (3)	5.	Mating/Unmating Force (3)
6.	LLCR (2)	6.	Cycles Quantity = 25 Cycles	6.	Cycles Quantity = 25 Cycles	6.	Cycles Quantity = 25 Cycles
7.	Max Delta = 15 mOhm	7.	Mating/Unmating Force (3)	7.	Mating/Unmating Force (3)	7.	Mating/Unmating Force (3)
8.	Humidity (1)	8.	Cycles Quantity = 25 Cycles	8.	Cycles Quantity = 25 Cycles	8.	Cycles Quantity = 25 Cycles
9.	LLCR (2)	9.	Mating/Unmating Force (3)	9.	Mating/Unmating Force (3)	9.	Mating/Unmating Force (3)
	Max Delta = 15 mOhm					10.	Thermal Shock (4)
						11.	Humidity (1)
						12.	Mating/Unmating Force (3)

(1) Humidity = EIA-364-31

Test Condition = B (240 Hours)

Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)

Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(3) Mating/Unmating Force = EIA-364-13

(4) Thermal Shock = EIA-364-32

Exposure Time at Temperature Extremes = 1/2 Hour

Method A, Test Condition = I (-55°C to +85°C)

Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**IR/DWV****Pin-to-Pin**

<u>Group 1</u> HCMD-25-S-06.00-01-G SSQ-125-01-T-D 2 Assemblies		<u>Group 2</u> HCMD-25-S-06.00-01-G 2 Assemblies		<u>Group 3</u> SSQ-125-01-T-D 2 Assemblies		<u>Group 4</u> HCMD-25-S-06.00-01-G SSQ-125-01-T-D 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

Row-to-Row

<u>Group 5</u> HCMD-25-S-06.00-01-G SSQ-125-01-T-D 2 Assemblies		<u>Group 6</u> HCMD-25-S-06.00-01-G 2 Assemblies		<u>Group 7</u> SSQ-125-01-T-D 2 Assemblies		<u>Group 8</u> HCMD-25-S-06.00-01-G SSQ-125-01-T-D 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

- (1) DWV at Test Voltage = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (2) DWV Breakdown = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (3) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b
- (4) IR = EIA-364-21
Test Condition = 500 Vdc, 2 Minutes Max
- (5) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**Current Carrying Capacity**

Group 1
 HCMD-36-D-12.00-01-G
 SSQ-136-01-T-D
 2 Pins Powered
 Signal

Step	Description
1.	CCC ⁽¹⁾ Rows = 2 Number of Positions = 1

Group 2
 HCMD-36-D-12.00-01-G
 SSQ-136-01-T-D
 4 Pins Powered
 Signal

Step	Description
1.	CCC ⁽¹⁾ Rows = 2 Number of Positions = 2

Group 3
 HCMD-36-D-12.00-01-G
 SSQ-136-01-T-D
 6 Pins Powered
 Signal

Step	Description
1.	CCC ⁽¹⁾ Rows = 2 Number of Positions = 3

Group 4
 HCMD-36-D-12.00-01-G
 SSQ-136-01-T-D
 8 Pins Powered
 Signal

Step	Description
1.	CCC ⁽¹⁾ Rows = 2 Number of Positions = 4

Group 5
 HCMD-36-D-12.00-01-G
 SSQ-136-01-T-D
 72 Pins Powered
 Signal

Step	Description
1.	CCC ⁽¹⁾ Rows = 2 Number of Positions = 36

(1) CCC = EIA-364-70

Method 2, Temperature Rise Versus Current Curve

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

FLOWCHARTS Continued**Mechanical Shock/Random Vibration/LLCR**Group 1

HCMD-25-S-12.00-01-G

SSQ-125-01-T-D

8 Assemblies

Step Description

1. LLCR ⁽¹⁾
2. Mechanical Shock ⁽²⁾
3. Random Vibration ⁽³⁾
4. LLCR ⁽¹⁾
Max Delta = 15 mOhm

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mechanical Shock = EIA-364-27

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(3) Random Vibration = EIA-364-28

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

Mechanical Shock/Random Vibration/Event DetectionGroup 1

HCMD-25-S-12.00-01-G

SSQ-125-01-T-D

60 Points

Step Description

1. Nanosecond Event Detection
(Mechanical Shock) ⁽¹⁾
2. Nanosecond Event Detection
(Random Vibration) ⁽²⁾

(1) Nanosecond Event Detection (Mechanical Shock)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-27 for Mechanical Shock:

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-28 for Random Vibration:

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

FLOWCHARTS Continued**Cable Pull**Group 1

HCMD-25-D-12.00-01-G

SSQ-125-01-T-D

5 Assemblies

0 Degrees

Step Description

1. Cable Pull ⁽¹⁾

Group 2

HCMD-25-D-12.00-01-G

SSQ-125-01-T-D

5 Assemblies

90 Degrees

Step Description

1. Cable Pull ⁽¹⁾

(1) Cable Pull = EIA-364-38

Measure and Record Force Required to Failure

Failure = Discontinuity >1 microsecond at 10 ohms

Cable FlexGroup 1

HCMD-25-D-16.00-01-G

SSQ-125-01-T-D

8 Assemblies

Flat Cable

Step Description

1. IR ⁽³⁾
2. DWV at Test Voltage ⁽²⁾
Note: USE IR/DWV Test Voltage
3. Cable Flex ⁽¹⁾
4. Visual Inspection
5. IR ⁽³⁾
6. DWV at Test Voltage ⁽²⁾
Note: USE IR/DWV Test Voltage

(1) Cable Flex = EIA-364-41

Circular Jacket Cable - to be tested 90° each direction (180° total)

Flat Cable - to be tested 70° each direction (140° total)

Monitor continuity during flex testing

Failure = Discontinuity >1 microsecond at 10 ohms

(2) DWV at Test Voltage = EIA-364-20

Test Condition = 1 (Sea Level)

DWV test voltage is equal to 75% of the lowest breakdown voltage

Test voltage applied for 60 seconds

(3) IR = EIA-364-21

Test Condition = 500 Vdc, 2 Minutes Max

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL SHOCK:

- 1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors*.
- 2) Test Condition 1: -55°C to +85°C
- 3) Test Time: ½ hour dwell at each temperature extreme
- 4) Number of Cycles: 100
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

THERMAL:

- 1) EIA-364-17, *Temperature Life with or without Electrical Load Test Procedure for Electrical Connectors*.
- 2) Test Condition 4 at 105° C
- 3) Test Time Condition B for 250 hours.
- 4) All test samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

- 1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors*.
- 2) Test Condition B, 240 Hours.
- 3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

MECHANICAL SHOCK (Specified Pulse):

- 1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
- 2) Test Condition C
- 3) Peak Value: 100 G
- 4) Duration: 6 Milliseconds
- 5) Wave Form: Half Sine
- 6) Velocity: 12.3 ft/s
- 7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

- 1) Reference document: EIA-364-28, *Vibration Test Procedure for Electrical Connectors*
- 2) Test Condition V, Letter B
- 3) Power Spectral Density: 0.04 G² / Hz
- 4) G 'RMS': 7.56
- 5) Frequency: 50 to 2000 Hz
- 6) Duration: 2.0 Hours per axis (3 axis total)

NANOSECOND-EVENT DETECTION:

- 1) Reference document: EIA-364-87, *Nanosecond-Event Detection for Electrical Connectors*
- 2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
- 3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

MATING/UNMATING:

- 1) Reference document: EIA-364-13, *Mating and Unmating Forces Test Procedure for Electrical Connectors*.
- 2) The full insertion position was to within 0.003" to 0.004" of the plug bottoming out in the receptacle to prevent damage to the system under test.
- 3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
- 2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
- 3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
- 4) The size of the temperature probe can affect the measured temperature.
- 5) Copper traces on PC boards will contribute to temperature rise:
 - a. Self heating (resistive)
 - b. Reduction in heat sink capacity affecting the heated contacts
- 6) A de-rating curve, usually 20%, is calculated.
- 7) Calculated de-rated currents at four temperature points are reported:
 - a. Ambient
 - b. 65° C
 - c. 75° C
 - d. 95° C
- 8) Typically, neighboring contacts (in close proximity to maximize heat build up) are energized.
- 9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
- 10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
- 11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
- 12) Hook-up wire length is longer than the minimum specified in the referencing standard.

LLCR:

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms:----- Stable
 - b. $+5.1$ to $+10.0$ mOhms:----- Minor
 - c. $+10.1$ to $+15.0$ mOhms:----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:----- Marginal
 - e. $+50.1$ to $+2000$ mOhms:----- Unstable
 - f. $>+2000$ mOhms:----- Open Failure

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

GAS TIGHT:

To provide method for evaluating the ability of the contacting surfaces in preventing penetration of harsh vapors which might lead to oxide formation that may degrade the electrical performance of the contact system.

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms:----- Stable
 - b. $+5.1$ to $+10.0$ mOhms:----- Minor
 - c. $+10.1$ to $+15.0$ mOhms:----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:----- Marginal
 - e. $+50.1$ to $+2000$ mOhms:----- Unstable
 - f. $>+2000$ mOhms:----- Open Failure
- 4) Procedure:
 - a. Reference document: EIA-364-36, *Test Procedure for Determination of Gas-Tight Characteristics for Electrical Connectors, Sockets and/or Contact Systems*.
 - b. Test Conditions:
 - i. Class II--- Mated pairs of contacts assembled to their plastic housings.
 - ii. Reagent grade Nitric Acid shall be used of sufficient volume to saturate the test chamber
 - iii. The ratio of the volume of the test chamber to the surface area of the acid shall be 10:1.
 - iv. The chamber shall be saturated with the vapor for at least 15 minutes before samples are added.
 - v. Exposure time, 55 to 65 minutes.
 - vi. The samples shall be no closer to the chamber walls than 1 inches and no closer to the surface of the acid than 3 inches.
 - vii. The samples shall be dried after exposure for a minimum of 1 hour.
 - viii. Drying temperature 50°C
 - ix. The final LLCR shall be conducted within 1 hour after drying.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Electrification Time 2.0 minutes
 - iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
- 2) MEASUREMENTS:
- 3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 1000 megohms.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Barometric Test Condition 1
 - iii. Rate of Application 500 V/Sec
 - iv. Test Voltage (VAC) until breakdown occurs
- 2) MEASUREMENTS/CALCULATIONS
 - a. The breakdown voltage shall be measured and recorded.
 - b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
 - c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

CONNECTOR PULL:

- 1) Secure cable near center and pull on connector
 - a. At 90°, right angle to cable
 - b. At 0°, in-line with cable



Fig. 1
0° Connector pull

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

CABLE FLEX:

- 1) Oscillate and monitor electrical continuity for open circuit indication.
 - a. $\pm 70^\circ$ Pendulum Mode, bend up to 500 cycles with 16 oz. load on cable end.



Fig. 2
Cable flex

RESULTS

Temperature Rise, CCC at a 20% de-rating

- CCC for a 30°C Temperature Rise-----4.7 A per contact with 2 contacts (2x1) powered
- CCC for a 30°C Temperature Rise-----3.5 A per contact with 4 contacts (2x2) powered
- CCC for a 30°C Temperature Rise-----3.0 A per contact with 6 contacts (2x3) powered
- CCC for a 30°C Temperature Rise-----2.7 A per contact with 8 contacts (2x4) powered
- CCC for a 30°C Temperature Rise-----1.6 A per contact with 72 contacts (2x36) powered

Mating – Unmating Forces

Thermal Aging Group (HCMD-25-S-06.00-01-G/SSQ-125-01-T-D)

- Initial
 - Mating
 - Min -----25.35 Lbs
 - Max-----28.58 Lbs
 - Unmating
 - Min -----9.72 Lbs
 - Max-----13.41 Lbs
- After Thermal
 - Mating
 - Min -----19.15 Lbs
 - Max-----21.46 Lbs
 - Unmating
 - Min -----7.93 Lbs
 - Max-----10.92 Lbs

RESULTS Continued**Mating – Unmating Forces****Mating-Unmating Durability Group (HCMD-25-S-06.00-01-G/SSQ-125-01-T-D)**

- **Initial**
 - **Mating**
 - **Min** -----25.14 Lbs
 - **Max** -----28.86 Lbs
 - **Unmating**
 - **Min** ----- 9.28 Lbs
 - **Max** -----14.59 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** -----28.33 Lbs
 - **Max** -----32.15 Lbs
 - **Unmating**
 - **Min** ----- 8.64 Lbs
 - **Max** -----15.23 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** -----27.98 Lbs
 - **Max** -----35.49 Lbs
 - **Unmating**
 - **Min** ----- 8.45 Lbs
 - **Max** -----14.78 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** -----29.94 Lbs
 - **Max** -----35.78 Lbs
 - **Unmating**
 - **Min** ----- 8.41 Lbs
 - **Max** -----14.01 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** -----31.12 Lbs
 - **Max** -----36.40 Lbs
 - **Unmating**
 - **Min** ----- 7.78 Lbs
 - **Max** -----13.78 Lbs
- **Humidity**
 - **Mating**
 - **Min** -----16.98 Lbs
 - **Max** -----23.84 Lbs
 - **Unmating**
 - **Min** ----- 8.04 Lbs
 - **Max** -----11.71 Lbs

RESULTS Continued**Mating – Unmating Forces****Mating-Unmating Basic (HCMD-36-S-06.00-01-G/SSQ-136-01-T-D)**

- **Initial**
 - **Mating**
 - **Min** -----32.61 Lbs
 - **Max** -----38.50 Lbs
 - **Unmating**
 - **Min** -----15.05 Lbs
 - **Max** -----18.33 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** -----36.64 Lbs
 - **Max** -----42.01 Lbs
 - **Unmating**
 - **Min** -----11.54 Lbs
 - **Max** -----16.65 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** -----40.54 Lbs
 - **Max** -----46.79 Lbs
 - **Unmating**
 - **Min** -----11.28 Lbs
 - **Max** -----14.64 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** -----40.35 Lbs
 - **Max** -----48.78 Lbs
 - **Unmating**
 - **Min** -----10.64 Lbs
 - **Max** -----14.26 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** -----44.44 Lbs
 - **Max** -----49.05 Lbs
 - **Unmating**
 - **Min** -----10.00 Lbs
 - **Max** -----15.07 Lbs

RESULTS Continued**Mating – Unmating Forces****Mating-Unmating Basic (HCMD-05-S-06.00-01-G/SSQ-105-01-T-D)**

- **Initial**
 - **Mating**
 - **Min** ----- 4.62 Lbs
 - **Max** ----- 5.25 Lbs
 - **Unmating**
 - **Min** ----- 3.09 Lbs
 - **Max** ----- 4.59 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** ----- 5.55 Lbs
 - **Max** ----- 6.23 Lbs
 - **Unmating**
 - **Min** ----- 3.25 Lbs
 - **Max** ----- 4.74 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** ----- 6.45 Lbs
 - **Max** ----- 7.39 Lbs
 - **Unmating**
 - **Min** ----- 3.50 Lbs
 - **Max** ----- 4.80 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** ----- 7.05 Lbs
 - **Max** ----- 8.19 Lbs
 - **Unmating**
 - **Min** ----- 3.61 Lbs
 - **Max** ----- 4.89 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** ----- 7.55 Lbs
 - **Max** ----- 8.21 Lbs
 - **Unmating**
 - **Min** ----- 3.59 Lbs
 - **Max** ----- 4.98 Lbs

Cable Pull Force**0° Pull**

- **Min** ----- 9.45 Lbs
- **Max** ----- 11.12 Lbs

90° Pull

- **Min** ----- 40.55 Lbs
- **Max** ----- 47.50 Lbs

RESULTS Continued**Insulation Resistance minimums, IR****Pin to Pin**

- **Initial**
 - Mated -----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- **Thermal Shock**
 - Mated -----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- **Humidity**
 - Mated -----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed

Row to Row

- **Initial**
 - Mated -----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- **Thermal Shock**
 - Mated -----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- **Humidity**
 - Mated -----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed

Dielectric Withstanding Voltage minimums, DWV

- **Minimums**
 - Breakdown Voltage ----- 1375 VAC
 - Test Voltage ----- 1035 VAC
 - Working Voltage -----340 VAC

Pin to Pin

- **Initial DWV** -----Passed
- **Thermal DWV**-----Passed
- **Humidity DWV**-----Passed

Row to Row

- **Initial DWV** -----Passed
- **Thermal DWV**-----Passed
- **Humidity DWV**-----Passed

CABLE FLEX**Insulation Resistance minimums, IR****Pin to Pin**

- **Initial**
 - Mated -----45000 Meg Ω ----- Passed
- **After flex test**
 - Mated -----45000 Meg Ω ----- Passed

Row to Row

- **Initial**
 - Mated -----45000 Meg Ω ----- Passed
- **After flex test**
 - Mated -----45000 Meg Ω ----- Passed

RESULTS Continued**LLCR Thermal Aging Group (192 LLCR test points)**

- **Initial** ----- 36.21 mOhms Max
- **Thermal**
 - <= +5.0 mOhms ----- 192 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

LLCR Mating/Unmating Durability Group (192 LLCR test points)

- **Initial** ----- 34.65 mOhms Max
- **Durability, 100 Cycles**
 - <= +5.0 mOhms ----- 180 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 12 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Thermal Shock**
 - <= +5.0 mOhms ----- 183 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 9 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Humidity**
 - <= +5.0 mOhms ----- 181 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 11 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

LLCR Gas Tight Group (192 LLCR test points)

- **Initial** ----- 34.83 mOhms Max
- **Gas-Tight**
 - <= +5.0 mOhms ----- 192 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

RESULTS Continued

LLCR Shock & Vibration Group (192 LLCR test points)

- **Initial ----- 66.17 mOhms Max**
- **Shock &Vibration**
 - **<= +5.0 mOhms ----- 192 Points ----- Stable**
 - **+5.1 to +10.0 mOhms -----0 Points ----- Minor**
 - **+10.1 to +15.0 mOhms -----0 Points ----- Acceptable**
 - **+15.1 to +50.0 mOhms -----0 Points ----- Marginal**
 - **+50.1 to +2000 mOhms -----0 Points ----- Unstable**
 - **>+2000 mOhms -----0 Points ----- Open Failure**

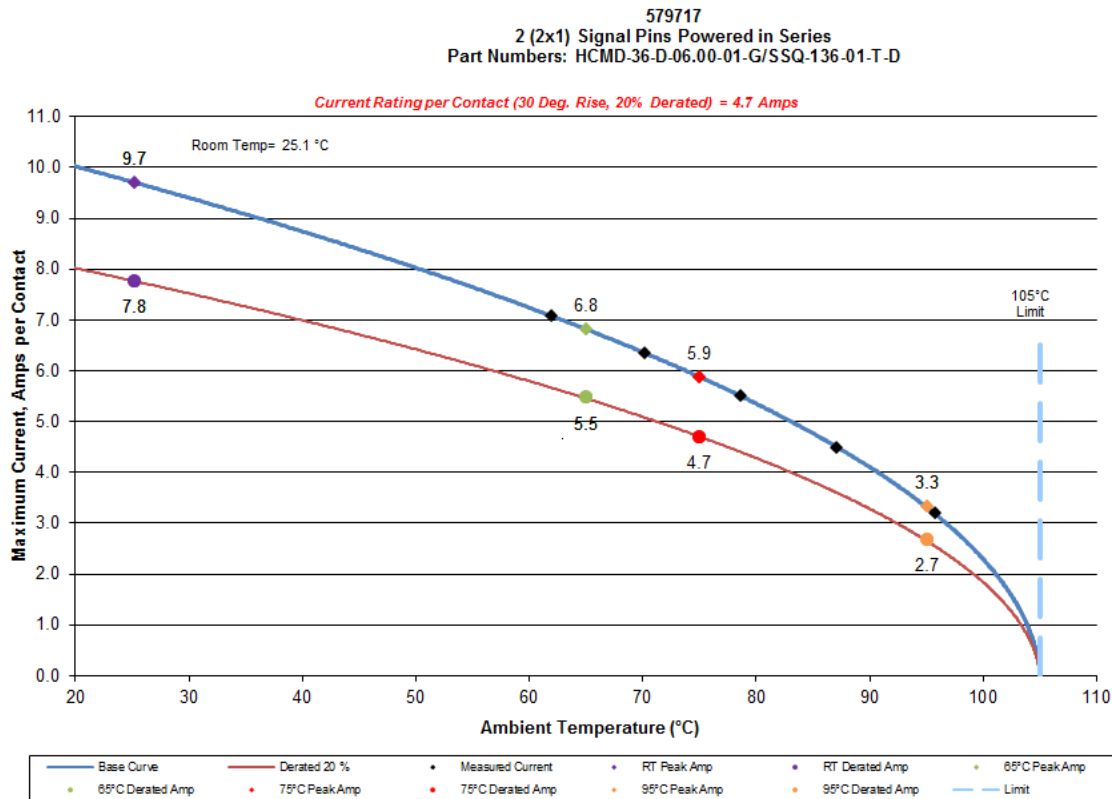
Mechanical Shock & Random Vibration:

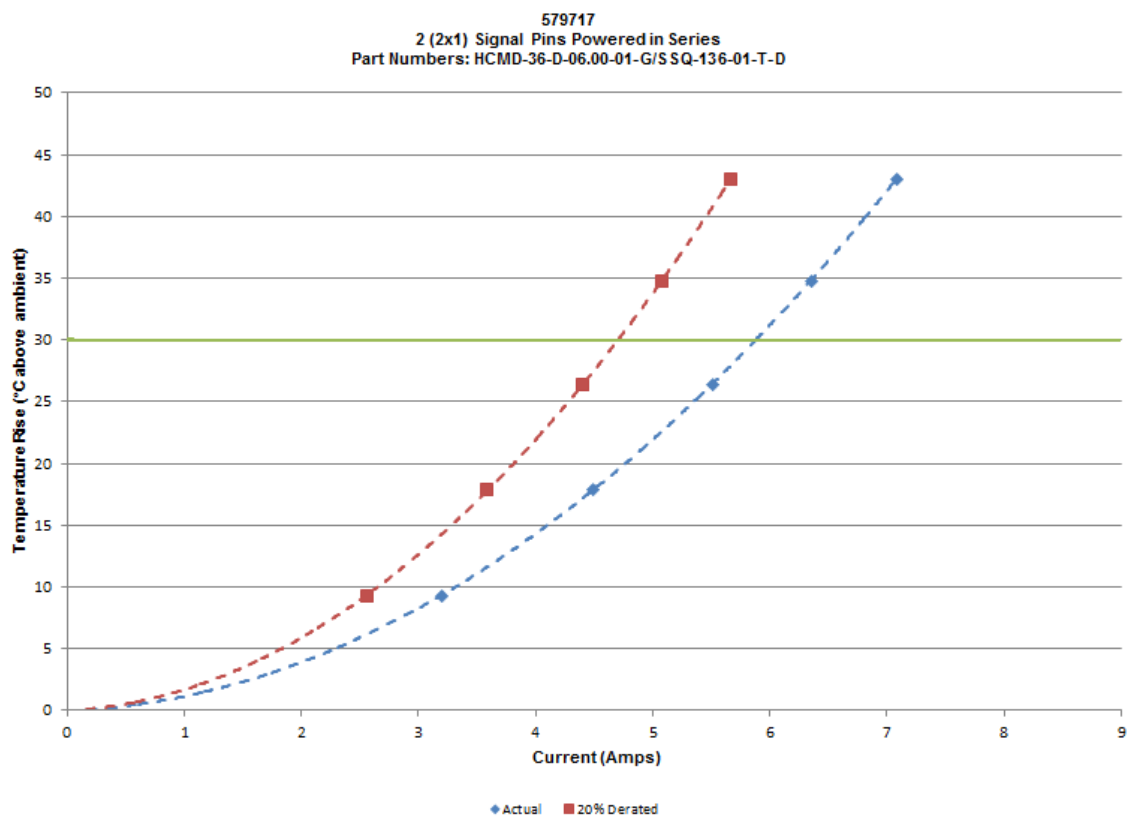
- **Shock**
 - **No Damage----- Pass**
 - **50 Nanoseconds----- Pass**
- **Vibration**
 - **No Damage----- Pass**
 - **50 Nanoseconds----- Pass**

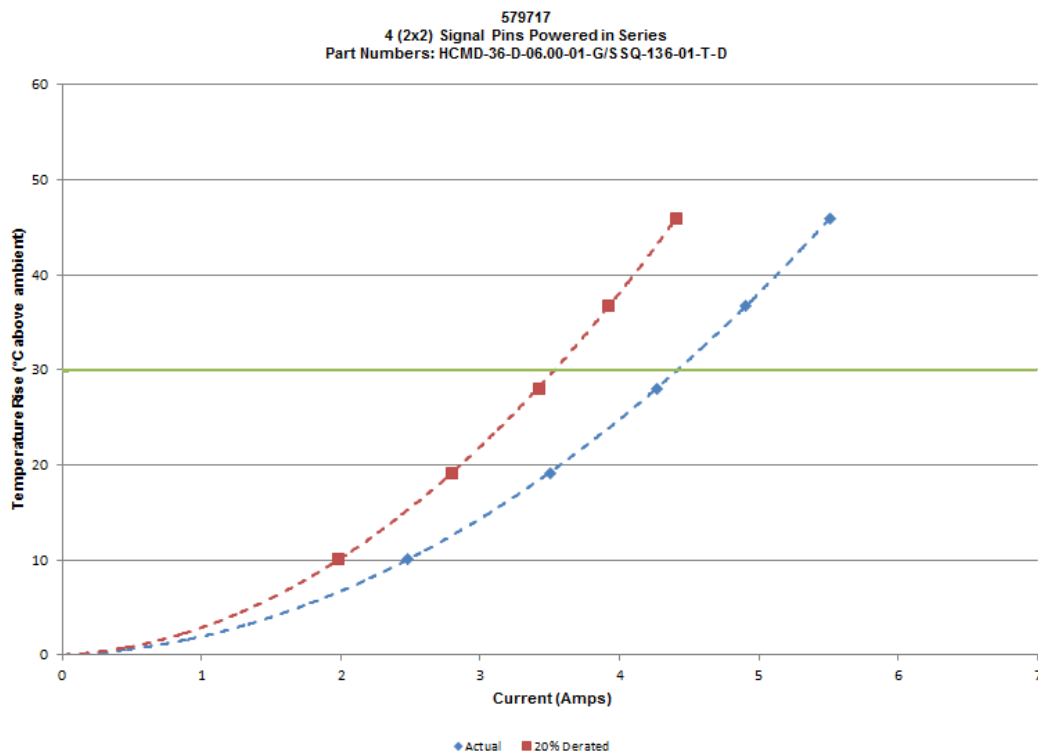
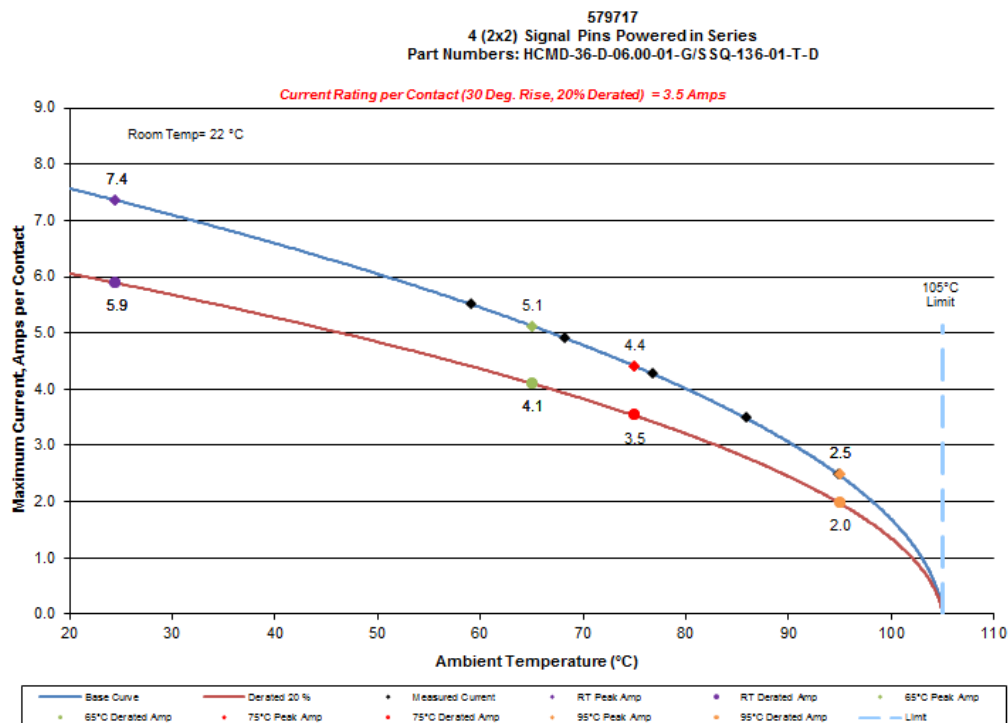
DATA SUMMARIES**TEMPERATURE RISE (Current Carrying Capacity, CCC):**

- 1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
- 2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
- 3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer controlled data acquisition).
- 4) Adjacent contacts were powered:

a. Linear configuration with 2 adjacent conductors/contacts powered

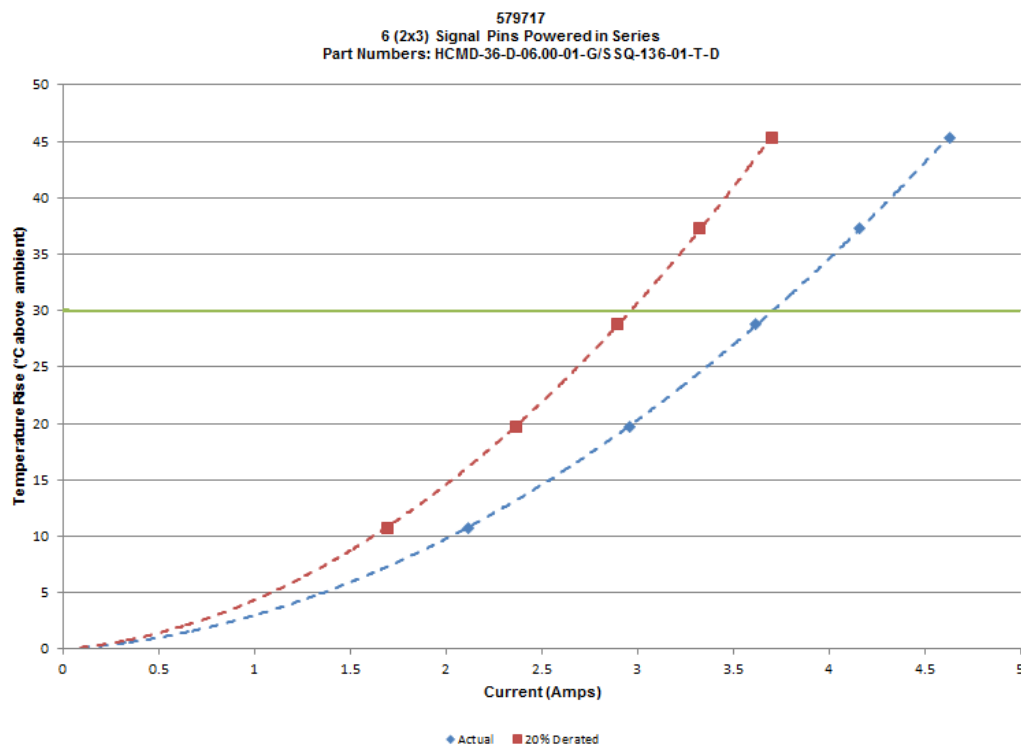
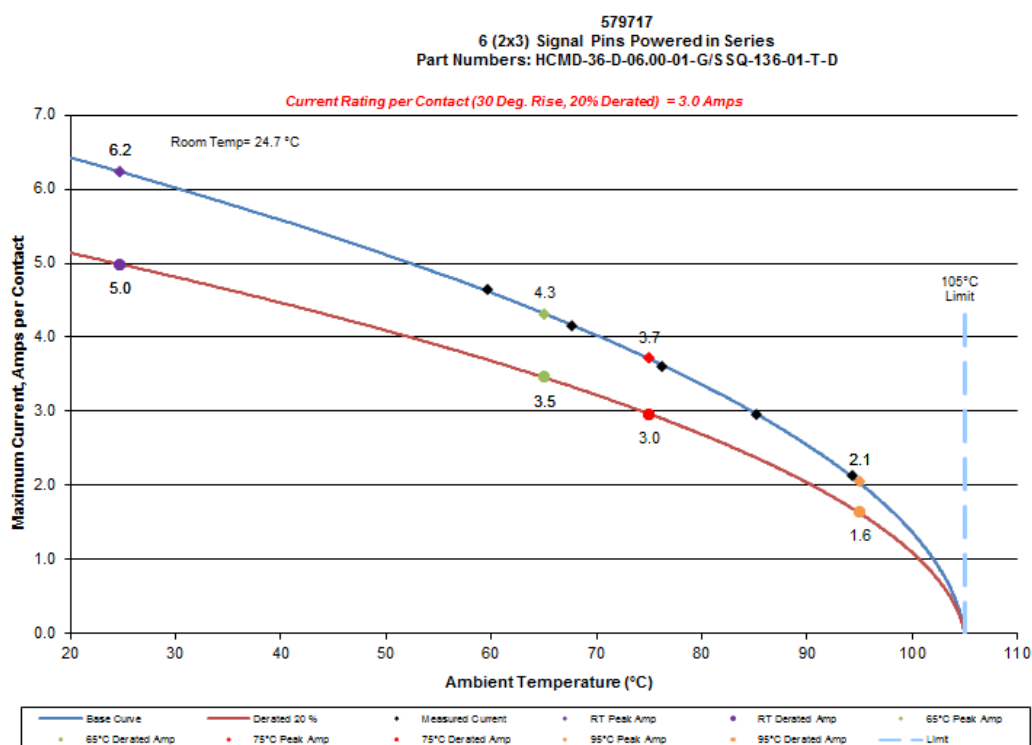


DATA SUMMARIES Continued

DATA SUMMARIES Continued**b. Linear configuration with 4 adjacent conductors/contacts powered**

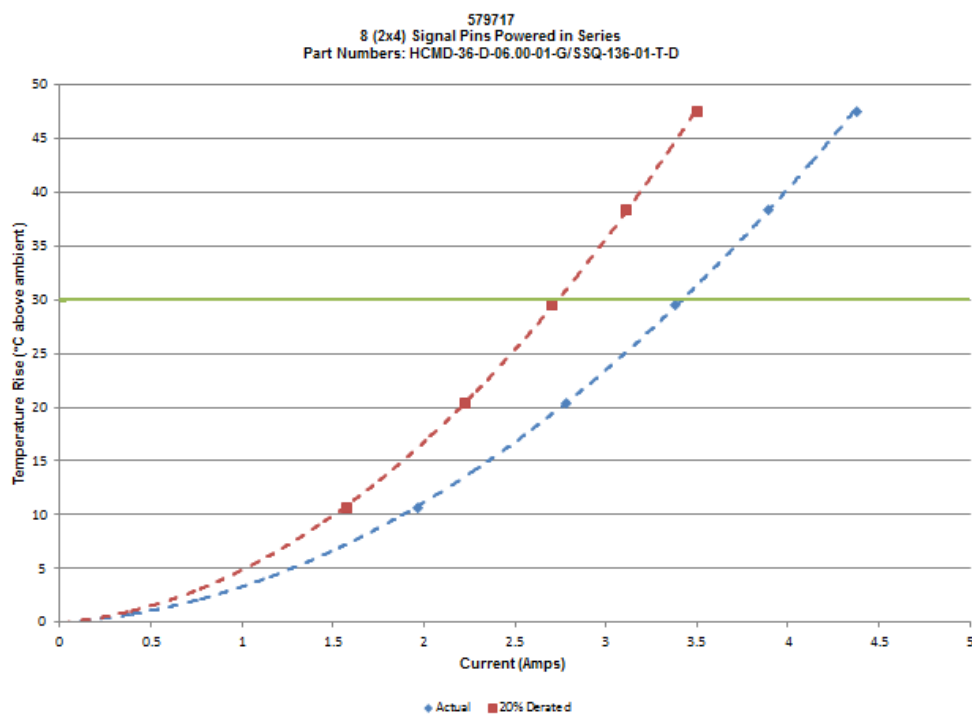
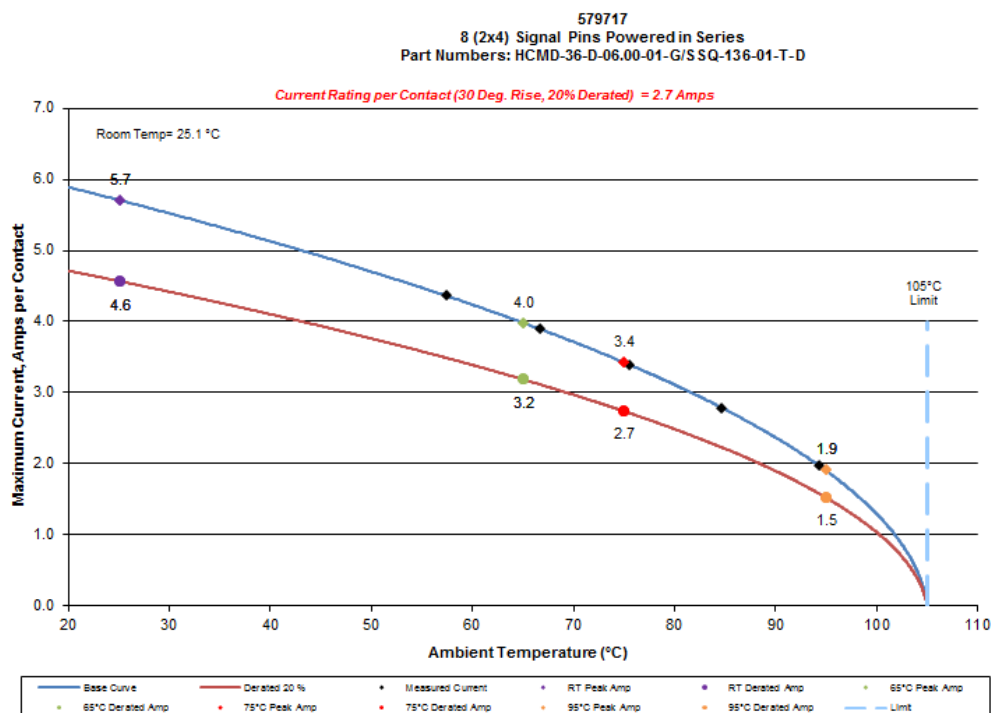
DATA SUMMARIES Continued

c. Linear configuration with 6 adjacent conductors/contacts powered



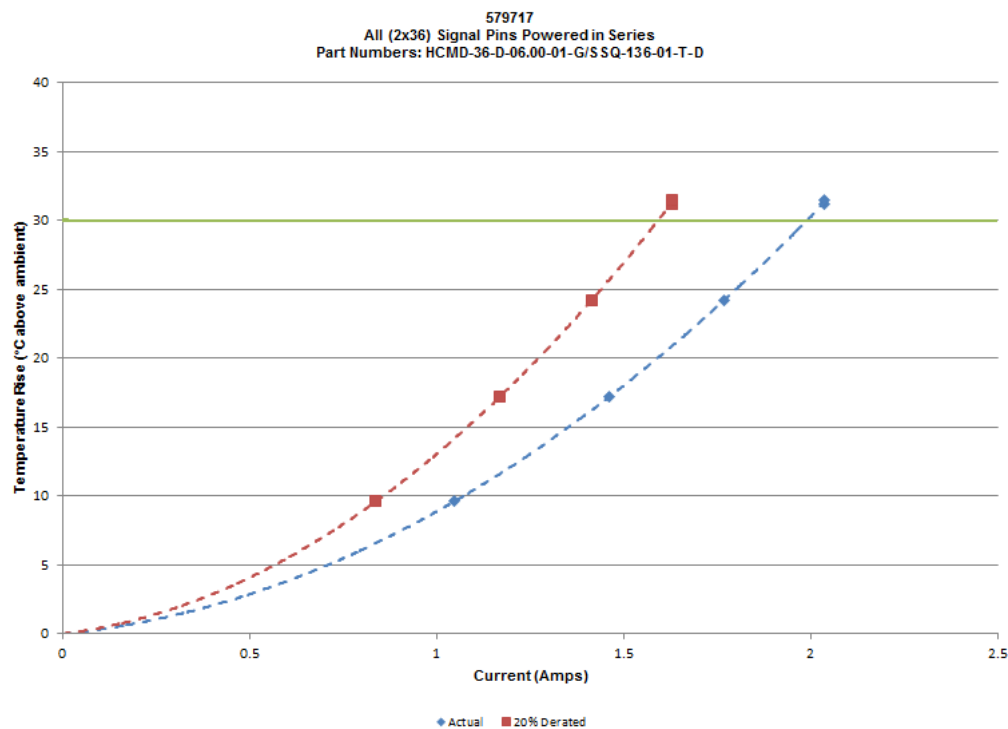
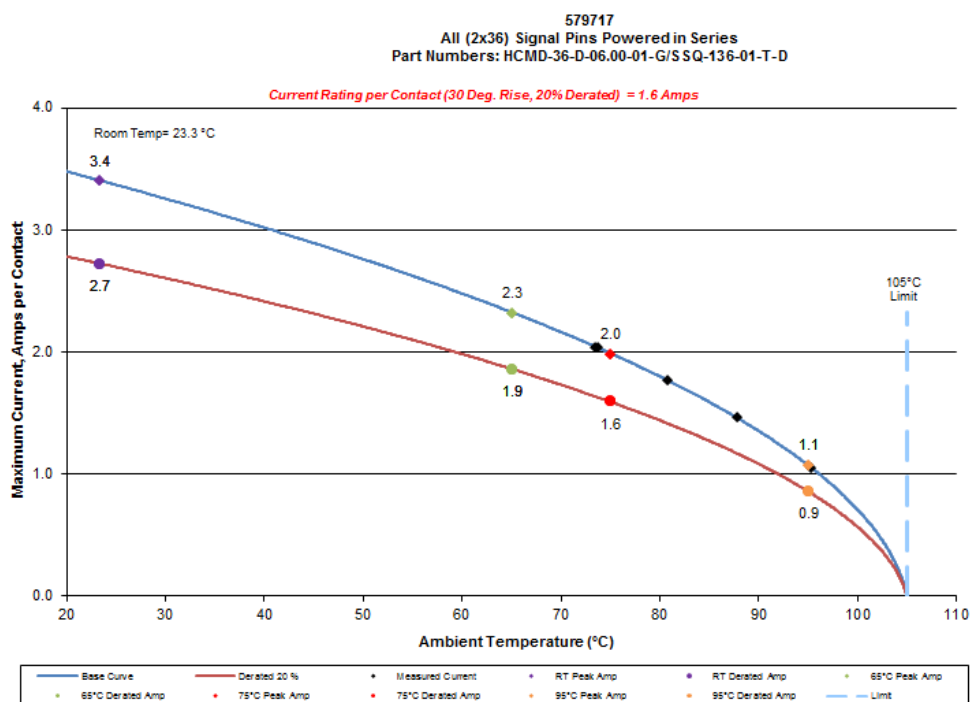
DATA SUMMARIES Continued

d. Linear configuration with 8 adjacent conductors/contacts powered



DATA SUMMARIES Continued

e. Linear configuration with all adjacent conductors/contacts powered



DATA SUMMARIES Continued**MATING-UNMATING FORCE:****Thermal Aging Group (HCMD-25-S-06.00-01-G/SSQ-125-01-T-D)**

	Initial				After Thermals			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	112.76	25.35	43.23	9.72	85.18	19.15	35.27	7.93
Maximum	127.12	28.58	59.65	13.41	95.45	21.46	48.57	10.92
Average	120.07	27.00	50.39	11.33	90.32	20.31	41.91	9.42
St Dev	5.09	1.15	4.89	1.10	3.73	0.84	4.18	0.94
Count	8	8	8	8	7	7	7	7

Mating-Unmating Durability Group (HCMD-25-S-06.00-01-G/SSQ-125-01-T-D)

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	111.82	25.14	41.28	9.28	126.01	28.33	38.43	8.64
Maximum	128.37	28.86	64.90	14.59	143.00	32.15	67.74	15.23
Average	117.13	26.33	53.44	12.02	131.51	29.57	51.53	11.59
St Dev	5.26	1.18	9.86	2.22	5.29	1.19	11.68	2.63
Count	8	8	8	8	8	8	8	8

	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	124.46	27.98	37.59	8.45	133.17	29.94	37.41	8.41
Maximum	157.86	35.49	65.74	14.78	159.15	35.78	62.32	14.01
Average	138.51	31.14	48.67	10.94	144.59	32.51	46.93	10.55
St Dev	9.70	2.18	9.72	2.19	8.01	1.80	9.14	2.06
Count	8	8	8	8	8	8	8	8

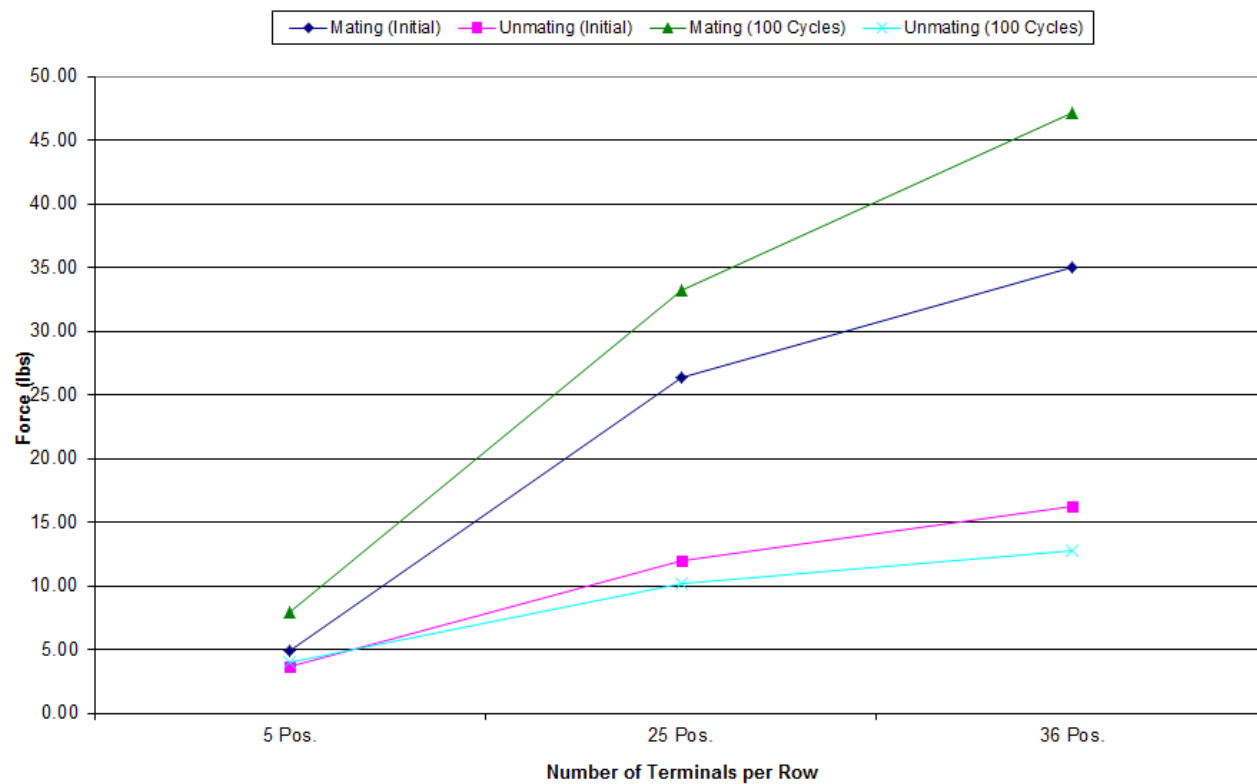
	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	138.42	31.12	34.61	7.78	75.53	16.98	35.90	8.07
Maximum	161.91	36.40	61.29	13.78	106.04	23.84	52.09	11.71
Average	147.49	33.16	45.18	10.16	86.47	19.44	42.91	9.65
St Dev	7.93	1.78	9.68	2.18	9.62	2.16	4.98	1.12
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**MATING-UNMATING FORCE:****Mating-Unmating Basic (HCMD-36-S-06.00-01-G/SSQ-136-01-T-D)**

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	145.05	32.61	66.94	15.05	162.97	36.64	51.33	11.54
Maximum	171.25	38.50	81.53	18.33	186.86	42.01	74.06	16.65
Average	155.67	35.00	72.08	16.21	177.51	39.91	66.48	14.95
St Dev	9.20	2.07	5.11	1.15	8.64	1.94	8.78	1.97
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	180.32	40.54	50.17	11.28	179.48	40.35	47.33	10.64
Maximum	208.12	46.79	65.12	14.64	216.97	48.78	63.43	14.26
Average	192.92	43.37	59.00	13.27	202.02	45.42	56.78	12.77
St Dev	9.89	2.22	6.31	1.42	11.55	2.60	6.62	1.49
Count	8	8	8	8	8	8	8	8
	After 100 Cycles							
	Mating		Unmating					
	Newtons	Force (Lbs)	Newtons	Force (Lbs)				
Minimum	197.67	44.44	44.48	10.00				
Maximum	218.17	49.05	67.03	15.07				
Average	209.81	47.17	56.61	12.73				
St Dev	7.23	1.63	8.58	1.93				
Count	8	8	8	8				

DATA SUMMARIES Continued**MATING-UNMATING FORCE:****Mating-Unmating Basic (HCMD-05-S-06.00-01-G/SSQ-105-01-T-D)**

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	20.55	4.62	13.74	3.09	24.69	5.55	14.46	3.25
Maximum	23.35	5.25	20.42	4.59	27.71	6.23	21.08	4.74
Average	21.79	4.90	16.40	3.69	26.52	5.96	16.98	3.82
St Dev	1.01	0.23	2.40	0.54	1.16	0.26	2.12	0.48
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	28.69	6.45	15.57	3.50	31.36	7.05	16.06	3.61
Maximum	32.87	7.39	21.35	4.80	36.43	8.19	21.75	4.89
Average	31.04	6.98	17.26	3.88	33.95	7.63	17.56	3.95
St Dev	1.44	0.32	2.02	0.45	1.46	0.33	2.11	0.47
Count	8	8	8	8	8	8	8	8
	After 100 Cycles							
	Mating		Unmating					
	Newtons	Force (Lbs)	Newtons	Force (Lbs)				
Minimum	33.58	7.55	15.97	3.59				
Maximum	36.52	8.21	22.15	4.98				
Average	35.29	7.94	17.81	4.01				
St Dev	0.94	0.21	2.19	0.49				
Count	8	8	8	8				

DATA SUMMARIES Continued**Mating\Unmating Force Comparison****Mating/Unmating Data for 5, 25 and 36 Position HCMD/SSQ****Cable Pull Force**
0° Pull

	Force (lbs)
Minimum	9.45
Maximum	11.12
Average	10.27

90° Pull

	Force (lbs)
Minimum	40.55
Maximum	47.50
Average	43.87

DATA SUMMARIES Continued**INSULATION RESISTANCE (IR):**

	Pin to Pin		
	Mated	Unmated	Unmated
Minimum	HCMD/SSQ	HCMD	SSQ
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

	Row to Row		
	Mated	Unmated	Unmated
Minimum	HCMD/SSQ	HCMD	SSQ
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary	
Minimum	HCMD/SSQ
Break Down Voltage	1375
Test Voltage	1035
Working Voltage	340

Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

Row to Row	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued**LLCR Thermal Aging Group**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms:-----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms:-----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:-----Marginal
 - e. $+50.1$ to $+2000$ mOhms-----Unstable
 - f. $>+2000$ mOhms:-----Open Failure

LLCR Measurement Summaries by Pin Type				
Date	7/20/2015	8/4/2015		
Room Temp (Deg C)	23	23		
Rel Humidity (%)	54	51		
Technician	Peter Chen	Peter Chen		
mOhm values	Actual	Delta	Delta	Delta
	Initial	Thermal		
Pin Type 1: Signal				
Average	33.32	0.14		
St. Dev.	0.56	0.29		
Min	31.90	0.00		
Max	36.21	1.99		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Thermal	192	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Mating/Unmating Durability Group**

- 1). A total of 192 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms ----- Unstable
 - f. $> +2000$ mOhms: ----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	8/16/2016	9/1/2016	9/8/2016	9/23/2016
Room Temp (Deg C)	23	23	23	23
Rel Humidity (%)	56	56	56	57
Technician	Peter Chen	Peter Chen	Peter Chen	Peter Chen
mOhm values	Actual	Delta	Delta Therm Shck	Delta Humidity
	Initial	100 Cycles		
Pin Type 1: Signal				
Average	33.78	1.26	1.17	1.32
St. Dev.	0.49	1.86	1.65	1.80
Min	31.41	0.01	0.00	0.01
Max	36.67	9.44	7.50	8.59
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	$>5 \text{ \& } \leq 10$	$>10 \text{ \& } \leq 15$	$>15 \text{ \& } \leq 50$	$>50 \text{ \& } \leq 1000$	>1000
100 Cycles	180	12	0	0	0	0
Therm Shck	183	9	0	0	0	0
Humidity	181	11	0	0	0	0

DATA SUMMARIES Continued**LLCR Gas Tight Group**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms: ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	8/12/2015	8/20/2015		
Room Temp (Deg C)	23	23		
Rel Humidity (%)	53	54		
Technician	Peter Chen	Peter Chen		
mOhm values	Actual Initial	Delta Acid Vapor	Delta	Delta
Pin Type 1: Signal				
Average	33.12	0.20		
St. Dev.	0.45	0.17		
Min	32.24	0.00		
Max	34.83	1.97		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Acid Vapor	192	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Shock & Vibration Group**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	10/9/2015	10/19/2015		
Room Temp (Deg C)	22	23		
Rel Humidity (%)	46	38		
Technician	Tony Wagoner	Tony Wagoner		
mOhm values	Actual Initial	Delta Shock-Vib	Delta	Delta
Pin Type 1: Signal				
Average	64.51	0.23		
St. Dev.	0.51	0.42		
Min	63.46	0.00		
Max	66.17	2.91		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
mOhms	Stable	Minor	Acceptable	Marginal	Unstable	Open
	≤ 5	$>5 \text{ \& } \leq 10$	$>10 \text{ \& } \leq 15$	$>15 \text{ \& } \leq 50$	$>50 \text{ \& } \leq 1000$	>1000
Shock-Vib	192	0	0	0	0	0

Nanosecond Event Detection:

Shock and Vibration Event Detection Summary	
Contacts tested	60
Test Condition	C, 100g's, 6ms, Half-Sine
Shock Events	0
Test Condition	V-B, 7.56 rms g
Vibration Events	0
Total Events	0

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** HZ-TCT-01**Description:** Normal force analyzer**Manufacturer:** Mecmesin Multitester**Model:** Mecmesin Multitester 2.5-i**Serial #:** 08-1049-04**Accuracy:** Last Cal: 4/26/2016, Next Cal: 4/25/2017**Equipment #:** HZ-OV-01**Description:** Oven**Manufacturer:** Huida**Model:** CS101-1E**Serial #:** CS101-1E-B**Accuracy:** Last Cal: 12/13/2015, Next Cal: 12/12/2016**Equipment #:** HZ-THC-01**Description:** Humidity transmitter**Manufacturer:** Thermtron**Model:** SM-8-8200**Serial #:** 38846**Accuracy:** Last Cal: 2/28/2016, Next Cal: 2/27/2017**Equipment #:** HZ-TSC-01**Description:** Vertical Thermal Shock Chamber**Manufacturer:** Cincinnatti Sub Zero**Model:** VTS-3-6-6-SC/AC**Serial #:** 10-VT14994**Accuracy:** See Manual

... Last Cal: 06/28/2016, Next Cal: 06/27/2017

Equipment #: HZ-HPM-01**Description:** NA9636H**Manufacturer:** Ainuo**Model:** 6031A**Serial #:** 089601091**Accuracy:** Last Cal: 3/7/2016, Next Cal: 3/6/2017**Equipment #:** HZ-MO-05**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 3706**Serial #:** 1285188**Accuracy:** Last Cal: 11/15/2015, Next Cal: 11/14/2016

EQUIPMENT AND CALIBRATION SCHEDULES Continued**Equipment #:** MO-04**Description:** Multimeter /Data Acquisition System**Manufacturer:** Keithley**Model:** 2700**Serial #:** 0798688**Accuracy:** See Manual

... Last Cal: 04/30/2016, Next Cal: 04/30/2017

Equipment #: HZ-MO-01**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 2700**Serial #:** 1199807**Accuracy:** Last Cal: 04/28/2016, Next Cal: 04/28/2017**Equipment #:** HZ-PS-01**Description:** Power Supply**Manufacturer:** Agilent**Model:** 6031A**Serial #:** MY41000982**Accuracy:** Last Cal: 04/28/2016, Next Cal: 04/28/2017**Equipment #:** SVC-01**Description:** Shock & Vibration Table**Manufacturer:** Data Physics**Model:** LE-DSA-10-20K**Serial #:** 10037**Accuracy:** See Manual

... Last Cal: 11/31/2015, Next Cal: 11/31/2016

Equipment #: ACLM-01**Description:** Accelerometer**Manufacturer:** PCB Piezotronics**Model:** 352C03**Serial #:** 115819**Accuracy:** See Manual

... Last Cal: 07/09/2016, Next Cal: 07/09/2017

Equipment #: ED-03**Description:** Event Detector**Manufacturer:** Analysis Tech**Model:** 32EHD**Serial #:** 1100604**Accuracy:** See Manual

... Last Cal: 06/04/2016, Next Cal: 06/04/2017